

Scattering of carriers by charged dislocations in semiconductors

Bhavtosh Bansal,^{1,a)} Rituparna Ghosh,¹ and V. Venkataraman²

¹Indian Institute of Science Education and Research Kolkata, Mohanpur Campus, Nadia 741252, West Bengal, India

²Department of Physics, Indian Institute of Science, Bangalore 560 012, India

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The scattering of carriers by charged dislocations in semiconductors is studied within the framework of the linearized Boltzmann transport theory with an emphasis on examining consequences of the extreme anisotropy of the cylindrically symmetric scattering potential. A new closed-form approximate expression for the carrier mobility valid for all temperatures is proposed. The ratios of quantum and transport scattering times are evaluated after averaging over the anisotropy in the relaxation time. The value of the Hall scattering factor computed for charged dislocation scattering indicates that there may be a factor of two error in the experimental mobility estimates using the Hall data. An expression for the resistivity tensor when the dislocations are tilted with respect to the plane of transport is derived. Finally, an expression for the isotropic relaxation time is derived when the dislocations are located within the sample with a uniform angular distribution. © 2013 AIP Publishing LLC. [<http://dx.doi.org/10.1063/1.4803121>]

I. INTRODUCTION

Epitaxial growth of thin semiconductor films on substrates which have a large lattice constant mismatch results in the films being strained. Depending on the growth conditions and the films' thickness, this strain can either partially or fully relax through a formation of various possible kinds of lattice defects. Among these defects, edge dislocations are prominent and have a pronounced effect on the mobility of carriers.¹ While the theory for charged dislocation scattering was first formulated to explain the low temperature mobility of plastically deformed semiconductors,² interest in dislocation scattering has revived in the last 15 years in context of GaN^{1,3-6} and InN⁸ which typically do not have lattice-matched substrates. Indeed it is important in all epitaxially grown materials^{9,10} on mismatched substrates, as well as bulk crystals whose growth techniques have not yet been mastered.¹¹

An edge dislocation is a row of dangling bonds formed by an abruptly terminated plane somewhere inside the crystal.³ This local departure from tetragonal coordination produces acceptor states in the energy gap, forming one dimensional lines of charge. The effective screened electrostatic potential energy, $U(x_{\perp})$ is thus cylindrically symmetric if the extent of the edge dislocation is taken to be infinite^{1,12,13}

$$U(x_{\perp}) = \frac{Qe}{2\pi\epsilon} K_0(x_{\perp}/\lambda), \quad (1)$$

where Q is the charge per unit length, K_0 is the modified zeroth order Bessel function of the second kind, $\epsilon = \epsilon_0\epsilon_r$ is the dielectric constant, λ is the screening length, and x_{\perp} is the distance from the dislocation line in a perpendicular plane, $\mathbf{r} = f(x_{\perp}, \theta, z)$. These one dimensional lines of charge have detrimental effects on the transport properties of charge carriers.

^{a)}Electronic address: bhavtosh@iiserkol.ac.in

II. ISSUES ADDRESSED

The importance of the carrier scattering by charged dislocations was established around the mid 1950s by the systematic observation of reduced electron mobility in plastically deformed germanium.¹⁴ Specific aspects of the problem have been studied in numerous theoretical and experimental papers over the past sixty years, but many of the theoretical results related to the calculation of mobility have been obtained in an ad hoc manner.

Given that there has been a revival of interest in this problem in context of mismatched epitaxy of semiconductors, here we have attempted a complete revisit of the electron transport problem in presence of charged dislocations within the linearized Boltzmann transport theory. The aim of this work is to give a coherent and mathematically consistent formulation and derive expressions for the transport relaxation time, quantum scattering time, mobility, Hall factor, resistivity tensor, and angular-averaged mobility. Since expressions for some of these quantities have of course also been derived previously in literature, our results are mentioned in context of the old results.

Specifically, the paper aims to address the following issues:

- (i) The scattering potential [Eq. (1)] is highly anisotropic due to its cylindrical symmetry. It is known that the relaxation time approximation for the solution of the linearized Boltzmann equation is in general not valid for anisotropic potentials. In context of the charged dislocation scattering also, the extension of the relaxation time approach has been questioned.^{3,5,15} We will, first of all, rigorously establish the existence of a relaxation time for this problem.
- (ii) We will next show that Pödör's expression for the relaxation time²

$$\tau = \frac{8\epsilon^2 m^{*2}}{N_d e^2 Q^2 \lambda} \left(\frac{\hbar^2}{4m^{*2} \lambda^2} + v_{\perp}^2 \right)^{3/2} \quad (2)$$

is indeed correct, despite an apparent inconsistency. In Eq. (2), v_{\perp} is the component of electron velocity perpendicular to the dislocation axis and N_d is the number of dislocations per unit area, all assumed to be parallel and independent. Only the perpendicular component of the impinging electron's velocity contributes to scattering and the component parallel to the dislocation is unaffected. Eq. (2) is finite when $v_{\perp} \rightarrow 0$, whereas in this limit, τ should diverge. This point gets clarified once one goes through a consistent derivation of the relation time in Sec. III where we break up the relaxation time into two components τ_{\perp} and τ_z . τ_{\perp} , the component of the relaxation time perpendicular to dislocations does indeed correspond to Pödör's expression whereas τ_z , the component parallel to the dislocation axes is ill-defined.

- (iii) The method of energy averaging employed by Pödör has been questioned.⁴ Due to this ambiguity, the tensor nature of resistivity is not evident in the final expression. In particular if the dislocations are tilted at an angle with respect to the direction perpendicular to the plane of transport, it is difficult to give anything better than a rough estimate in the present theory.⁷ The effect of dislocation orientation is usually disregarded and μ_{\perp} is replaced by a scalar number.¹ Nevertheless dislocation related anisotropy is sometimes seen in the transport properties.¹⁶
- (iv) Quantum and classical scattering times were calculated without averaging out the anisotropy in the problem.¹⁷
- (v) There are corrections to the measured Hall mobility due to the Hall scattering factor. This Hall factor is shown to be very significant, even larger than 2 for a non-degenerate electron gas.
- (vi) In general, dislocations may not be all parallel. A naive angular averaging over the resistivity tensor is equivalent to the use of Matthiessen's rule. We will derive a new expression for angular-averaged relation time $\tau_{iso}(k)$, which has a different k dependence as compared to the anisotropic relaxation time. Thus angular averaging has the important experimental consequence of changing the temperature dependence of mobility.

III. THEORETICAL FORMULATION

Let us start from the Boltzmann equation within the linear response regime.¹⁸ Then up to the first order in electric field, the perturbed distribution function may symbolically be written as $f_{\mathbf{k}} = f_{0\mathbf{k}} + \phi_{\mathbf{k}}$, where $\phi_{\mathbf{k}}$ is deviation from an equilibrium distribution in presence of a perturbing external electric field \mathbf{F} . In absence of a thermal gradient and a magnetic field, the linearized Boltzmann equation for carriers described by spherical parabolic band reduces to

$$\frac{e\hbar}{m^*} \mathbf{F} \cdot \mathbf{k} \frac{\partial f_{0\mathbf{k}}}{\partial E} = \sum_{\mathbf{k}'} W_{\mathbf{k},\mathbf{k}'} [\phi_{\mathbf{k}'} - \phi_{\mathbf{k}}]. \quad (3)$$

$W_{\mathbf{k},\mathbf{k}'}$ is the transition rate between initial and final plane wave states, \mathbf{k} and \mathbf{k}' , in presence of the scattering potential given by Eq. (1). For scattering from charged dislocations, the scattering rate is given by $W_{\mathbf{k},\mathbf{k}'} = \delta(k_z - k'_z) \delta(k - k') g(|\mathbf{k}_{\perp} - \mathbf{k}'_{\perp}|)$. $g(|\mathbf{k}_{\perp} - \mathbf{k}'_{\perp}|)$ is the part depending on only a function of in-plane momenta (shown below). Thus (a) collisions are elastic, (b) the components of the incident electron's momenta which are parallel and perpendicular to the dislocation line are separately conserved, (c) no electric field develops along the dislocation axis, i.e., $\mathbf{F} \cdot \mathbf{k} = \mathbf{F}_{\perp} \cdot \mathbf{k}_{\perp}$. This immediately implies that no relaxation time can be defined along the direction parallel to the dislocations' axis. In other words, for time independent electric field, there is no steady state solution to the Boltzmann equation if the collision term is zero. Nevertheless, one may physically argue that $1/\tau_z = 0$. The argument is clear within the variational formalism where one defines the sample resistivity in terms of the Joule-heat dissipated due to a finite current (see Appendix).¹⁸ With constraints (a)–(c) in mind, we shall choose a $\phi_{\mathbf{k}}$ which solves the linearized Boltzmann's equation *exactly*. *Ansatz*

$$\phi_{\mathbf{k}} = -\frac{e\hbar}{m^*} \tau_{\perp}(k_{\perp}) \mathbf{F}_{\perp} \cdot \mathbf{k}_{\perp} \frac{\partial f_{0\mathbf{k}}}{\partial E}. \quad (4)$$

Substituting $\phi_{\mathbf{k}}$ in Eq. (3) yields

$$\begin{aligned} \frac{\partial f_{0\mathbf{k}}}{\partial E} \mathbf{F}_{\perp} \cdot \mathbf{k}_{\perp} &= \mathbf{F}_{\perp} \cdot \sum_{\mathbf{k}'} W_{\mathbf{k},\mathbf{k}'} \\ &\times \left[\frac{\partial f_{0\mathbf{k}}}{\partial E} \tau_{\perp}(k_{\perp}) \mathbf{k}_{\perp} - \frac{\partial f_{0\mathbf{k}'}}{\partial E} \tau_{\perp}(k'_{\perp}) \mathbf{k}'_{\perp} \right]. \end{aligned} \quad (5)$$

From energy and perpendicular momentum conservation,

$$\frac{\partial f_{0\mathbf{k}'}}{\partial E} \tau_{\perp}(k'_{\perp}) = \frac{\partial f_{0\mathbf{k}}}{\partial E} \tau_{\perp}(k_{\perp}). \quad (6)$$

Thus, the linearized Boltzmann equation is exactly solved if

$$\frac{1}{\tau_{\perp}(k_{\perp})} = \sum_{\mathbf{k}'} W_{\mathbf{k},\mathbf{k}'} (1 - \cos \theta). \quad (7)$$

Here, θ is the angle between \mathbf{k}_{\perp} , \mathbf{k}'_{\perp} which lie on a circle parallel to the xy-plane since k_z is independently conserved. The wave vectors in the summation in Eq. (7) are three dimensional.

Within the Born approximation

$$W_{\mathbf{k},\mathbf{k}'} = \frac{2\pi}{\hbar} \delta(E_{\mathbf{k}} - E_{\mathbf{k}'}) \left[\frac{1}{L_x L_y L_z} \int d\mathbf{x} U(x_{\perp}) e^{i(\mathbf{k} - \mathbf{k}') \cdot \mathbf{x}} \right]^2. \quad (8)$$

Here, L_z , L_y and L_x are the crystal dimensions over which the plane wave electron states are normalized and the length of the “infinite” dislocation has been limited to the size of the crystal along the z direction. $U(x_{\perp})$ is already defined in Eq. (1) and it does not depend on the z coordinate. So going to cylindrical coordinates, the z integral is just a delta function. To take the normalization, assume a finite box of size L_z along the z axis. Therefore, $\int_{-\infty}^{\infty} dz e^{i(k_z - k'_z)z} \approx L_z \delta_{k_z, k'_z}$. With $\delta_{k_z, k'_z}^2 = \delta_{k_z, k'_z}$, we have

$$W_{\mathbf{k},\mathbf{k}'} = \frac{2\pi}{\hbar} \delta(E_k - E_{k'}) \delta_{k_z, k'_z} \times \left[\frac{L_z}{L_x L_y L_z} \frac{Qe}{2\pi\epsilon} \int d\mathbf{x}_\perp K_0(x_\perp/\lambda) e^{i(\mathbf{k}_\perp - \mathbf{k}'_\perp) \cdot \mathbf{x}_\perp} \right]^2. \quad (9)$$

The θ integral in Eq. (9) is just the integral representation of the zero-order modified Bessel function of first kind, J_0 ; $\int_0^{2\pi} d\theta \exp(i|\mathbf{k}_\perp - \mathbf{k}'_\perp| x_\perp \cos \theta) = 2\pi J_0(|\mathbf{k}_\perp - \mathbf{k}'_\perp| x_\perp)$. Further using the identity¹⁹ $\int_0^\infty y dy K_\nu(ay) J_\nu(by) = \frac{b^\nu}{a^\nu(a^2+b^2)}$, here $\nu = 0$, the Fourier transform in Eq. (9) becomes⁴

$$U(|\mathbf{k}_\perp - \mathbf{k}'_\perp|) = \frac{Qe\lambda^2}{\epsilon(1 + |\mathbf{k}_\perp - \mathbf{k}'_\perp|^2 \lambda^2)}. \quad (10)$$

The energy conserving delta function, $\delta(E_k - E_{k'}) = (\partial E/\partial k)^{-1} \delta(k - k') = (\hbar^2 k/m^*)^{-1} (k/k_\perp) \delta(k_\perp - k'_\perp)$ due to δ_{k_z, k'_z} in the summation. Thus, as previously claimed, both the perpendicular and the parallel components of the electron momenta are separately conserved. Since, $\Sigma_{\mathbf{k}'_\perp} \rightarrow L_x L_y / (2\pi)^2 \int d\mathbf{k}'_\perp$, an overall factor of area remains in the denominator after the primed momenta have been integrated over. This simply means that the scattering due to a single charged dislocation is ineffective in a large sample.²⁰ When there are many charged dislocations within this area which are all parallel, one can simply replace $(L_x L_y)^{-1}$ by N_d the dislocation density per unit area if the interference terms can be neglected.

IV. RESULTS

A. Transport lifetime

From Eq. (7), the relaxation time in the direction perpendicular to the dislocation axis is

$$\tau_\perp(k_\perp) = \frac{\hbar^3 \epsilon^2}{Q^2 e^2 \lambda^4 m^* N_d} [1 + (2k_\perp \lambda)^2]^{3/2}. \quad (11)$$

This is exactly what Pödör had derived [Eq. (2)] and $k_\perp = 0$ implies a finite τ_\perp even after our rederivation. While in three dimensions an electron with $k = 0$ is unphysical (there is no associated phase space), an electron with $k_\perp = 0$ and $k_z \neq 0$ corresponds to a physical situation. The inconsistency in the final formula results from the breakdown of the validity of the assumed solution, $\phi_{\mathbf{k}} = 0$ for $k_\perp = 0$ in Eq. (4). This condition is outside the scope of the present scheme of the solution, which is otherwise consistent.

The anisotropy in τ necessitates a further angular averaging for a comparison with any physical quantity associated with a measurement which involves a thermodynamic distribution of electrons. This transport scattering time is directly connected to mobility, $\mu = (e/m) \langle \langle \tau \rangle \rangle$, where $\langle \langle \rangle \rangle$ denote an energy average, (see below) over a distribution function of appropriate degeneracy. In a fully degenerate system, using Eq. (15), this simplifies to $\langle \langle \tau_r \rangle \rangle = (3/4) \int_0^\pi \sin^3 \theta \tau_\perp d\theta$.

B. Quantum scattering time

A quantum scattering time, $\tau_\perp^q(k_\perp)$ is, by definition, Eq. (7), but without the $(1 - \cos \theta)$ factor and may be calculated similarly. This was done by Jena and Mishra.¹⁷

$$\tau_\perp^q(k_\perp) = \frac{\hbar^3 \epsilon^2}{Q^2 e^2 \lambda^4 m^* N_d} \frac{[1 + (2k_\perp \lambda)^2]^{3/2}}{1 + 2(k_\perp \lambda)^2}. \quad (12)$$

However, the angular dependence of τ_\perp^q must also to be averaged out. The meaningful quantity is $\langle 1/\tau^q \rangle = (2/\pi) \int_0^{\pi/2} [\tau^q(\theta)]^{-1} d\theta$ and is often connected to the finite amplitude and width of the Shubnikov-de Haas or de Haas-van Alphen oscillations. The quantum scattering time may be looked upon as an effective “Dingle” temperature, $T_D \sim (\hbar/2\pi k_B) \langle 1/\tau^q \rangle$.

Nevertheless, while comparing Shubnikov amplitudes, the scattering rates are better calculated between Landau wave functions and with a density of states at the Fermi level modified by the magnetic field, as was done long back by Vinokur for the essentially the same problem.²¹

Furthermore, literature on the connection between scattering times for dislocations’ strain field and de Haas-van Alphen oscillation amplitudes in metals was a subject of lively debate sometime back. Many parallel interpretations for level broadening have been suggested.²² Some semiclassical arguments even favour a small angle cutoff. This fact may be particularly important in two dimensions where it could rescue the quantum scattering time from a divergence¹⁷ in a simple and physically meaningful way, the small angle cutoff θ_c (in radians) being inversely proportional to the Landau level index n , $\theta_c \simeq \pi/2n$.^{23,24}

Despite the preceding remarks, the concept of a quantum scattering time finds a widespread use in literature (for example, Refs. 24–26). Therefore, we have plotted the suitably defined ratio $\langle 1/\tau^q \rangle / \langle \langle \tau_r \rangle \rangle$ of the transport and quantum scattering times for a three dimensional degenerate carrier gas in Fig. 1. The graph is plotted as a function of the dimensionless parameter, k_F/q_{TF} . q_{TF} is the simple wave vector independent Thomas-Fermi screening function. The largeness of this ratio is often regarded as a measure of “anisotropy” of scattering.²⁷ The real space anisotropy of the dislocation potential is different from the anisotropy in its Fourier transform, which is more a measure of the effective range of the potential. An additional averaging causes the transport to

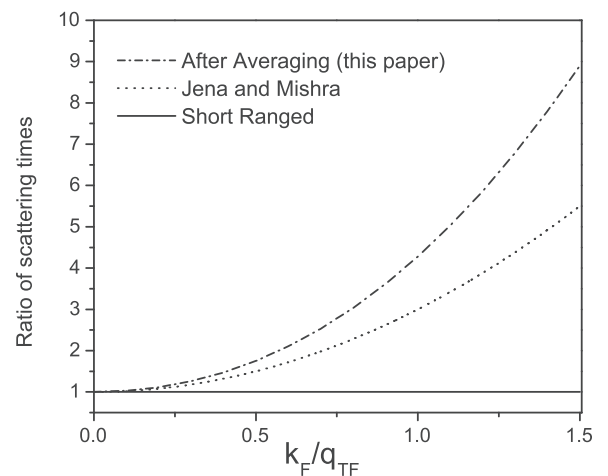


FIG. 1. The ratio of dislocation scattering limited transport and quantum scattering times for a degenerate electron gas.

quantum scattering times ratio to be larger than what was calculated by in Ref. 17.

C. Mobility

In calculating mobility, the averaging procedure employed by Pödör has been called “unspecified” and hence it is worked out below.⁴ For dislocations along the z-axis, the current and electric field directions coincide as long as the measurement is done in the xy-plane. Then, $j_x = ne\langle v_x \rangle$ and $\langle v_x \rangle = \mu_{\perp} F_x$, where

$$\langle v_x \rangle = \frac{\sum_{\mathbf{k}} (f_{0k} + \phi_{\mathbf{k}}) v_x}{\sum_{\mathbf{k}} (f_0 + \phi_{\mathbf{k}})} = \frac{\sum_{\mathbf{k}} \phi_{\mathbf{k}} v_x}{\sum_{\mathbf{k}} f_{0k}} \quad (13)$$

or

$$\sigma_{xx} = \frac{e^2 \hbar^2}{m^{*2}} \frac{2}{(2\pi)^3} \int k_x^2 \left(-\frac{\partial f_0}{\partial E} \right) \tau_{\perp}(k_{\perp}) d^3k \quad (14)$$

or

$$\sigma_{xx} = \frac{\hbar^5 \epsilon^2}{2\pi^2 m^{*3} Q^2 N_d \lambda^4} \int_0^{\pi} d\theta \sin^3 \theta \times \int_0^{\infty} dk k^4 \left(-\frac{\partial f_0}{\partial E} \right) [1 + (2k\lambda \sin \theta)^2]^{3/2}. \quad (15)$$

The integrals must now be evaluated numerically. Eq. (15) has the unpleasant feature of depending very strongly on screening length and thus at low temperatures turns out to be dependent on the model used for the temperature dependent of carrier concentration and screening. A simple analytic expression *guessed* by interpolating the two integrals ($\int d\theta$ and $\int dk$) between the two extremes cases, when the first term is much smaller and when it is much larger than the second term in square brackets in Eq. (15). This is significantly better than Pödör's high temperature approximation ($k\lambda \sin \theta \gg 1$).¹² The relative percentage errors are plotted in Fig. 2 as a function of the dimensionless parameter $\frac{8m^* k_B T \lambda^2}{\hbar^2}$.

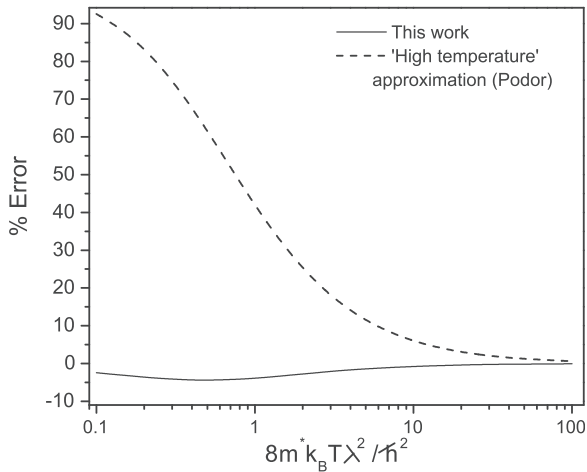


FIG. 2. The relative percentage errors ($\frac{\mu_{\text{exact}} - \mu_{\text{approx}}}{\mu_{\text{exact}}} \times 100$) in our formula and Pödör's approximation with respect to the exact expression evaluated numerically. The graphs are plotted as a function of dimensionless parameter $\frac{8m^* k_B T \lambda^2}{\hbar^2}$.

It can be seen that this approximation of the integral never deviates from the numerically calculated exact answer by more than 5%.

Assuming that the electrons are distributed according to Maxwell-Boltzmann distribution,

$$\mu_{\perp} \simeq \frac{2\hbar^3 \epsilon^2}{e\pi^{1/2} m^{*2} Q^2 N_d \lambda^4} \left[\pi^{1/3} + \left(\frac{15\pi}{8} \right)^{2/3} \frac{8\lambda^2 m^* k_B T}{\hbar^2} \right]^{3/2} \quad (16)$$

and when the carrier gas is fully degenerate

$$\mu_{\perp}^{\text{deg}} \simeq \frac{3\hbar^5 \epsilon^2}{4m^{*3} Q^2 N_d \lambda_{TF}^4} [(4/3)^{2/3} + (5\pi/16)^{2/3} 4k_F^2 \lambda_{TF}^2]^{3/2}. \quad (17)$$

D. Hall factor

In most experiments, it is not the drift but the Hall mobility which is measured. Under the assumption that the scattering rate does not alter in presence of a magnetic field, B and when the magnetic field is aligned with the dislocations' axis, only the in-plane relaxation time comes into the picture. Using the same line of arguments, it is easy to again establish its existence for arbitrarily strong non-quantizing magnetic fields. Then, if $j_x = \sigma_{xx} E_x + \sigma_{xy} E_y$, the Hall scattering factor r_H is defined as

$$r_H = n e \frac{\sigma_{xy}}{B \sigma_{xx}^2}, \quad (18)$$

where the off-diagonal conductivity, σ_{xy} , for carriers with parabolic energy dispersion which are distributed along isotropic constant energy surfaces is

$$\sigma_{xy} = \frac{e^3 B}{\hbar^2 m^*} \int \frac{d^3k}{4\pi^3} \tau_{\perp}^2 \frac{\partial f_0}{\partial E} \left(\frac{\partial E}{\partial k_x} \right)^2 \left[1 + \left(\frac{e\tau_{\perp} B}{m^*} \right)^2 \right]^{-1}. \quad (19)$$

From Eqs. (14), (19), and (18), the Hall scattering factor for nondegenerate carriers at high temperatures (i.e., $\frac{8m^* k_B T \lambda^2}{\hbar^2} \gg 1$) approaches a value of 2.07, obtained by dropping the second term in square brackets in Eq. (14). At lower temperatures, its value is dependent on the model of carrier density and screening but always smaller. The anisotropy in scattering makes the value higher than the Hall factor for ionized impurity scattering which is 1.93. We see that there can even be a factor of two error in the mobility estimate if the Hall mobility is equated to the drift mobility.

E. Effect of dislocation tilt

Assume that dislocations are all parallel, but now at a longitude ϕ and latitude θ with respect to the z-axis while the measurement is being done in the xy-plane. A unit vector along this dislocation axis is $\hat{\mathbf{d}} = \hat{\mathbf{x}} \sin \theta \sin \phi + \hat{\mathbf{y}} \sin \theta \cos \phi + \hat{\mathbf{z}} \cos \theta$. Because the electric field is developed only along the direction perpendicular to the dislocations' axis, $\mathbf{F}_{\perp} = \rho \mathbf{j}_{\perp} = \rho [\mathbf{j} - (\mathbf{j} \cdot \hat{\mathbf{d}}) \hat{\mathbf{d}}]$ which yields (with cos and sin abbreviated to c and s)

$$\rho' = \rho \begin{bmatrix} 1 - s^2 \theta s^2 \phi & -s^2 \theta s \phi c \phi & -c \theta s \theta s \phi \\ -s^2 \theta s \phi c \phi & 1 - s^2 \theta c^2 \phi & -c \theta s \theta s \phi \\ -c \theta s \theta s \phi & -c \theta s \theta s \phi & 1 - c^2 \theta \end{bmatrix}. \quad (20)$$

Negative sign in the off diagonals indicates the direction of the electric field developed. Note that tensor ρ' is symmetric, as it should be, to be consistent with Onsager relations.

F. Angular distribution of dislocations

The extreme anisotropy of the resistivity tensor is usually not seen experimentally. An obvious reason for this that all the dislocations are not parallel to each other. Let us consider the simplest case where the dislocation lines are distributed with a uniform distribution over angles. One can, of course, average over the angles appearing in Eq. (20).²⁸ This averaging over the angles in the rotated resistivity tensor amounts the use of Matthiessen's rule and will not change the temperature dependence of mobility.

For a better approximation, we again start from the linearized Boltzmann equation, Eq. (3). In the present case, the relaxation time must be isotropic and therefore let the *Ansatz* for the distribution function be

$$\phi(k) = -\frac{\hbar e}{m} \frac{\partial f_{0k}}{\partial E_k} \tau_{iso}(k) \mathbf{k} \cdot \mathbf{F}. \quad (21)$$

We shall further assume incoherent scattering such that the scattering rates due to different dislocation lines add. If the scattering rate due to an i^{th} dislocation is $W_{\mathbf{k},\mathbf{k}'}^i$, then the total rate is $\sum_i W_{\mathbf{k},\mathbf{k}'}^i$.

Without loss of generality, one can choose the electron wave vector \mathbf{k} to be along the z-axis, $\mathbf{k} = k\hat{z}$. If the axis of the i^{th} dislocation, \mathbf{d}^i is at an angle (θ, ϕ) with respect to the z-axis, then the unit vector along the dislocation axis is given by $\hat{d}^i = \sin \theta \sin \phi \hat{x} + \sin \theta \cos \phi \hat{y} + \cos \theta \hat{z}$. The component of the wave vector perpendicular to the dislocation axis is given by

$$\mathbf{k}_\perp = \mathbf{k} - (\mathbf{k} \cdot \mathbf{d}^i) \hat{d}^i$$

or

$$\mathbf{k}_\perp^i = k [(1 - \cos^2 \theta) \hat{z} - \cos \theta \sin \theta \cos \phi \hat{y} - \cos \theta \sin \theta \sin \phi \hat{x}]. \quad (22)$$

Substituting back in the Boltzmann equation, we get

$$F_z k_z = -\tau_{iso}(k) \mathbf{F} \cdot \sum_i \left[-\mathbf{k}_\perp^i \frac{1}{\tau(k_\perp^i)} \right]. \quad (23)$$

Converting the sum into an integral,

$$F_z k_z = \tau_{iso}(k) \frac{1}{4\pi} \mathbf{F} \cdot \int d\Omega \mathbf{k}_\perp^i \frac{1}{\tau(k_\perp^i)}. \quad (24)$$

Since the averaging over the dislocation orientations is equivalent to an averaging over the electron wave vectors, the expression for the relaxation time becomes

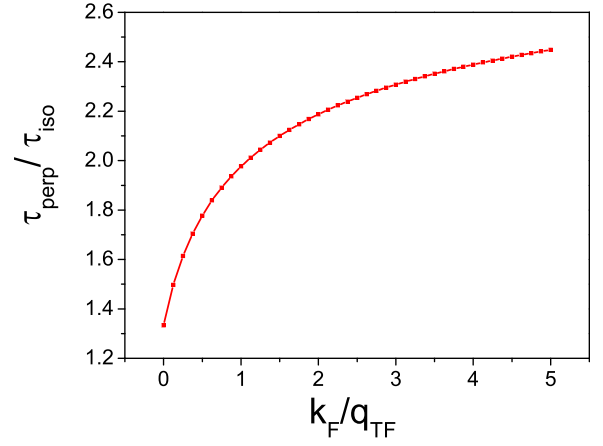


FIG. 3. The ratio of dislocation scattering limited transport and isotropic scattering times for a degenerate electron gas.

$$\frac{1}{\tau_{iso}(k)} = \frac{Q^2 e^2 \lambda^4 m^* N_d}{2 \hbar^3 \epsilon^2} \int_0^\pi d\theta \frac{\sin^3 \theta}{[1 + 4k^2 \lambda^2 \sin^2 \theta]^{3/2}}, \quad (25)$$

where the ϕ integral has been performed and we have noted that $\int_0^{2\pi} d\phi \sin \phi = \int_0^{2\pi} d\phi \cos \phi = 0$. From here on, it is straightforward to calculate the isotropic mobility, although it is best done numerically.²⁹ Fig. 3 shows ratio of the perpendicular to the isotropic scattering times for a degenerate electron gas as a function of the dimensionless ratio k_F / q_{TF} where k_F is the Fermi wave vector and q_{TF} is the Fourier transform of the (for example Thomas-Fermi) screening length.

V. SUMMARY

In this paper, we attempted to comprehensively formulate the problem of electron transport in semiconductors in presence of charged dislocations within the framework of the conventional linearized Boltzmann transport theory with the aim of filling gaps in the existing theory and to derive several new results. We showed that a relaxation time can be defined for scattering of carriers by charged dislocations. Difference between quantum and classical scattering times was discussed and it was pointed out that the anisotropy necessitates an appropriate angular averaging. A new approximate formula for mobility was derived and it was shown to be within 5% of the exact result at all temperatures. The value of the Hall scattering factor and the effect of dislocation tilt on resistivity were determined. Finally, we derived a new expression for the relaxation time when the angular orientation of dislocations is isotropic.

APPENDIX: VARIATIONAL CALCULATION OF MOBILITY

As a consistency check, let us also consider another method of calculating mobility that avoids the notion of a relaxation time altogether. Following Ziman, one can attempt a direct computation of resistivity using thermodynamic arguments and the variational principle.¹⁸ In presence of an external electric field, we can write an electron distribution function $f_{\mathbf{k}}$ that is shifted from its $k=0$ mean value at

equilibrium as $f_{\mathbf{k}} = f_{0\mathbf{k}} - \Phi_{\mathbf{k}} \frac{\partial f_{0\mathbf{k}}}{\partial \epsilon_{\mathbf{k}}}$. $\zeta_{\mathbf{k}}$ is the energy gained by the electron from the applied electric field. $\Phi_{\mathbf{k}}$ and $\phi_{\mathbf{k}}$ of Sec. III are obviously related, $\phi_{\mathbf{k}} = -\Phi_{\mathbf{k}} \frac{\partial f_{0\mathbf{k}}}{\partial \epsilon_{\mathbf{k}}}$. The entropy generated per unit time due to current j caused by the applied electric field through the Joule heat dissipated in the material on account of its finite resistivity is $\dot{S} = \rho j^2 / T$. Using this thermodynamic argument and the (approximate) expression for entropy in terms of the (perturbed) distribution function, one can write down an expression for resistivity in terms of $\Phi_{\mathbf{k}}$ and the scattering rates $W_{\mathbf{k},\mathbf{k}'}$.

$$\rho = \frac{2\pi^3}{k_B T} \frac{\sum_{\mathbf{k}'} \int d\mathbf{k} W_{\mathbf{k},\mathbf{k}'} [\Phi_{\mathbf{k}} - \Phi_{\mathbf{k}'}]^2 f_{0\mathbf{k}} [1 - f_{0\mathbf{k}'}]}{\left[\int d\mathbf{k} e v_{\mathbf{k}} \Phi_{\mathbf{k}} \frac{\partial f_{0\mathbf{k}}}{\partial \epsilon_{\mathbf{k}}} \right]^2}. \quad (\text{A1})$$

$W_{\mathbf{k},\mathbf{k}'}$ are the same as those computed in Sec. III. According to the variational principle, for any trial function $\Phi_{\mathbf{k}}$ the value of the ratio in Eq. (A1) will be greater than or equal to the value of true resistivity, i.e., Eq. (A1) will yield an upper bound of the true resistivity. Thus the computation of resistivity within this framework involves guessing a form for the $\Phi_{\mathbf{k}}$ in terms of a variational parameter s and then determining the value of s that minimizes the resistivity computed via Eq. (A1). Writing our trial function³⁰

$$\Phi_{\mathbf{k}} = -\tau_0 \mathbf{k} \cdot \hat{\mathbf{u}} |k|^s, \quad (\text{A2})$$

where $\hat{\mathbf{u}}$ is a unit vector parallel to the applied electric field, we find that Eq. (25) in the high temperature limit yields

$$\rho = \frac{\pi^3 N_d Q^2 \lambda \hbar^3}{128 m^* (K_B T)^3 \epsilon^2} \frac{\Gamma(s+1)}{\Gamma((s+5)/2)}. \quad (\text{A3})$$

In the above equation, ρ is minimum for $s=3$. Hence, the calculated mobility using variational principle in high temperature limit is

$$\mu_{var} = \frac{768\sqrt{2}}{\pi^{3/2}} \frac{(K_B T)^{3/2} \epsilon^2}{m^{*1/2} e N_d Q^2 \lambda}. \quad (\text{A4})$$

Comparing this with the high temperature limit of expression for mobility computed in Eq. (15), we find that the two expressions only differ by a numerical constant with $\mu_{var} = 1.296 \mu_{\perp}$. Since the variational principle yields an upper bound on the electrical resistivity, a lower resistivity (high mobility) computed here is probably a better estimate though the small difference in the multiplicative constants appearing in the two expression is experimentally insignificant, especially because N_d is a never known that precisely.

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